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Broadband, millimeter-wave antireflection coatings for large-format, cryogenic aluminum oxide optics


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Abstract: We present two prescriptions for broadband (∼77–252 GHz), millimeter-wave antireflection coatings for cryogenic, sintered polycrystalline aluminum oxide optics: one for large-format (700 mm diameter) planar and plano-convex elements, the other for densely packed arrays of quasi-optical elements, in our case 5 mm diameter half-spheres (called “lenslets”). The coatings comprise three layers of commercially-available, polytetrafluoroethylene-based, dielectric sheet material. The lenslet coating is molded to fit the 150 mm diameter arrays directly while the large-diameter lenses are coated using a tiled approach. We review the fabrication processes for both prescriptions then discuss laboratory measurements of their transmittance and reflectance. In addition, we present the inferred refractive indices and loss tangents for the coating materials and the aluminum oxide substrate. We find that at 150 GHz and 300 K the large-format coating sample achieves (97 ± 2)% transmittance and the lenslet coating sample achieves (94 ± 3)% transmittance.

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1. Introduction

Current cosmic microwave background (CMB) experiments employ large diameter, efficient refractive optics [1–5]. Such optics will also be critical for next-generation CMB experiments, like CMB-S4 [6, 7]. Large, strong, low dielectric loss refractive optics can be constructed from silicon and sintered polycrystalline aluminum oxide (alumina). Materials such as silicon and alumina allow for optical designs with thinner, lower-curvature lenses than those employing lenses made...
from low-index plastic such as high-density polyethylene (HDPE) or ultra-high-molecular-weight polyethylene (UHMWPE) [8, 9]. Additionally, alumina and silicon lenses offer thermal and mechanical advantages: their relatively high thermal conductivity allows them to be cooled to cryogenic temperatures (∼4 K) with small thermal gradients across the optic; their rigid structures and low coefficients of thermal expansion (CTE) allow the lenses to resist deformation.

High purity, single-crystal silicon has a favorably high refractive index and low dielectric loss, but the maximum size of a silicon lens is limited by the size of commercially available silicon boules (<45 cm). These limits are mainly driven by pressure from the semiconductor industry, which uses the boules for batch device fabrication [10]. Alumina optics offer performance similar to silicon in important regions of the CMB observation spectrum, but they can be made with >70 cm diameter. The size of a single alumina part is limited by the diameter of the isostatic press used to compact the raw powder. However, if alumina parts larger than the press diameter are required, then sections can be compacted separately and fused into a single body at the sintering step [11]. In refracting telescope designs, the lens diameter limits the instrument’s resolution, so it is desirable to use as large a lens as possible. The lens diameter is especially important for low-frequency observations (e.g. within the ∼30 GHz to ∼40 GHz atmospheric transmission window). In addition, large-diameter optics allow for a focal plane with a large useable area, which provides more space for detectors. For experiments with detectors that are approximately photon shot-noise-limited, increasing the number of detectors is a means of increasing the experiment’s sensitivity. The South Pole Telescope’s third-generation survey camera (SPT-3G) employs such large-format, cryogenic, alumina refractive optics.

The high refractive indices (n ∼ 3) of alumina and silicon optics necessitate antireflection (AR) coatings to reduce reflections and maximize the overall instrument sensitivity. Developing cryogenic AR coatings for high-index optical elements is therefore an area of significant interest to the CMB instrumentation community—particularly as large-scale projects like CMB-S4 begin to ramp up.

Efficient, effective-medium coatings for silicon lenses have been successfully demonstrated. These coatings comprise sub-wavelength structures that are created by removing material from the lens surface [12]. While it is technically possible to use the same subtractive methods on an alumina lens, there are substantial practical hurdles to overcome. Alumina’s Vicker’s hardness is almost twice that of single-crystal silicon (20.1 GPa vs. 11.0 GPa) [13], which makes machining the material more difficult. The equipment needed to cut or laser-ablate the surface of a ∼70 cm diameter alumina lens currently only exists at commercial scale. Outsourcing a large lens for laser ablation could be done, but the long processing time required makes that approach expensive. One could build such a machine, but the technical expertise and time required to design, fabricate, verify, operate, and maintain it come at great cost. Additionally, errors made during subtractive processes may be impossible to correct, which is a considerable risk when the base cost of the unmodified lens (∼few ×10^4 USD and O(10) weeks lead time) is taken into account.

An alternative approach to the subtractive meta-material method is to layer the surface of the lens with materials that act as an AR coating. We present two such coatings for alumina substrates in this paper: one for densely packed arrays of quasi-optical elements (henceforth “lenslets”), the other for large-format lenses. §2 describes the coatings’ design and fabrication; §3 covers optical testing of the coatings. We present the results of the optical tests in §4 and discuss those results in §5.

2. Coating design and fabrication

A common type of AR coating is a quarter-wavelength coating, which can be optimized for a single frequency, or narrow range of frequencies. The material used for a coating of this type should have a refractive index equal to the geometric mean of the incident and substrate refractive indices, and its thickness should be one-quarter the in-material wavelength at the target
frequency [14]. This principle can be extended to a coating composed of multiple dielectric layers, which broadens the effective bandwidth of the coating.

We used the multilayer dielectric approach because the design of the SPT-3G survey camera required the coating to provide coverage from \( \sim 77 \) GHz to \( \sim 252 \) GHz [5]. SPT-3G observes the CMB in three bandpasses centered at 95 GHz, 150 GHz, and 220 GHz with \( \sim 25 \% \), \( \sim 21 \% \), and \( \sim 21 \% \) fractional bandwidth at each respective frequency. The bandpasses are designed to fall within atmospheric transmission windows where there is little atmospheric water vapor to attenuate the CMB radiation [15]. We found the refractive indices of porous polytetrafluoroethylene (PTFE) in the form of Zitex G-115 \( (n = 1.234) \), Porex PM-23J \( (n = 1.292) \), Rogers Corporation RO3035 bondply \( (n = 1.679) \), and Rogers Corporation RO3006 bondply \( (n = 2.249) \) to be suitable for an alumina lens coating. Each of the materials are PTFE matrices with non-PTFE inclusions that lower or raise the effective refractive index of the bulk material. The Zitex and Porex have \( \mu m \)-scale pores that reduce the refractive index below that of raw PTFE; the Rogers materials include high-index ceramic particles, which boosts the overall refractive index. The thickness of the RO3000-series bondply layers was dictated by their off-the-shelf availability: 0.127 mm in both cases. Though it is possible to specify an arbitrary thickness for the Zitex and Porex, we found the stock 0.381 mm thick material to be suitable.

We developed two coating prescriptions: one for large-format optics, and one for lenslet arrays. Figure 1 illustrates the layers and nominal thicknesses for both coating prescriptions. The SPT-3G

![Diagram of SPT-3G lens- and lenslet prescription AR coatings showing the materials and nominal thickness of each layer: (a) The lens-prescription coating uses intermediate LDPE bonding layers between the main dielectric layers and the alumina substrate; (b) The main dielectric materials of the lenslet-prescription coating are self-bonded and require no intermediate LDPE layers. It is bonded to the alumina substrate by a thin layer of Stycast 1266. The manufactured thickness of the Porex layer is 381 \( \mu \)m, but the layer is compressed during the bonding process. The thickness shown is typical of that layer after bonding.](image)

refractive optics and infrared filter are composed of CoorsTek AD-995 alumina; each element is \( \sim 720 \) mm in diameter. The infrared filter operates at \( \sim 50 \) K, while the refractive optics operate at \( \sim 4 \) K. The lenslets are hemispheres of 99.5 \% pure alumina with 5 mm outer diameter. They operate at \( \sim 300 \) mK, coupling CMB radiation that has passed through the refractive optics to the instrument’s detectors (Figure 2). The raw lenslets were produced by Kyocera and then ground to the hemispherical specification by TN Michigan (Hoover Precision at the time of manufacture).

The lenslet-prescription coating is self-bonded, requiring no adhesive layer between the dielectric layers (Figure 1b and Figure 3a). The layers are clamped together, then baked in a PID-controlled oven. At \( \sim 371 \) °C the PTFE molecules begin to coalesce and diffuse across layer boundaries. When the oven is cooled, the interlinked PTFE molecules crystallize, yielding a single sheet with three dielectric subsections (Figure 3b). Clamping and baking the coating typically decreases the thickness of the coating by \( \sim 60 \mu \)m (\( \sim 15 \% \)). The RO3035 and RO3006
layers are virtually incompressible, so all of the change in thickness occurs in the low-index Porex layer—this is due to pore collapse within the material. The decrease in thickness is offset by an increase in refractive index. In the limit that the Porex becomes fully dense, it should assume the refractive index of pure PTFE ($n = 1.44$). Once the laminated coating cools to room temperature, it is molded to fit the lenslet array by a die press. A calibrated volume of Stycast 1266 epoxy is then deposited at the apex of each lenslet, and the coating is secured to the lenslet array. After the epoxy cures, the coating is laser-diced to reduce thermal stress during the cooldown to 300 mK. The laser cuts a hexagonal pattern around each lenslet, separating it from its neighbors (Figure 3c–e).

The lens-prescription coating (Figure 1a) uses Zitex G-115 instead of Porex PM-23J as the low-index layer. For our purposes, the effective differences between the Zitex and Porex are small enough that we opt to use the lower cost Zitex for the large-format optics. The lens-prescription coating also incorporates $\sim 25.4 \mu m$ thick low-density polyethylene (LDPE) as an adhesive layer between the dielectric layers, instead of self-bonding and Stycast 1266 like the lenslet prescription. This is largely due to practical difficulties in self-bonding large coating sections and accurately aligning coating sections during layout. Simulations show the LDPE bonding layers slightly increase transmittance in the 95 GHz and 150 GHz bands while slightly reducing transmittance in the 220 GHz band (Figure 4). The coating is assembled one layer at a time by a vacuum-bagging process. The work piece is sealed in a mold from which the air is then evacuated. Atmospheric pressure outside the mold provides the force needed to laminate the coating layers. Each layer is baked at $140^\circ C$ during its initial layout. We find that once all layers are applied, a final bake at a soak temperature of $160^\circ C$ results in robust lamination.

The scale of the lenses causes additional complexities: the mismatch between alumina and PTFE’s coefficients of thermal expansion can result in coating delamination; there is also the problem of wrapping a curved surface with a flat sheet (Figure 5) [17]. It is not possible to coat the entire optical surface of the large-format SPT-3G optics without seams, in part due to the form factor of the raw materials. Therefore we opt for seam patterns that allow us to use the AR coating materials most efficiently and avoid unnecessary waste (Figure 6). Zitex-G115 is a pliable material and lays across flat and curved surfaces without issue, so we use it without modification (other than trimming it to width where necessary). The RO3035 and RO3006 materials are somewhat stiffer and are prone to tearing if they wrinkle, which is a problem when attempting to lay out a full sheet over a curved lens surface. We choose to use a radially symmetric petal-like pattern on curved surfaces for the RO3035 and RO3006 layers to avoid
Fig. 3: (a) Exploded-view schematic of the lenslet-prescription AR coating, lenslet, lenslet seating wafer, and detector wafer. The thin, red line called out by the red arrow marks the position of the Stycast 1266 layer; (b) Infrared photograph of a lenslet AR coating after lamination. Dashed lines mark the approximate boundaries of the original materials; (c) Cutaway of a lenslet AR coating after the molding and Stycast procedures. The coating and lenslet surface were marred during cross-sectioning; (d) Close-up photograph of an assembled, AR-coated, and laser-diced lenslet array; (e) Photograph of an AR-coated lenslet array. The array comprises 271 coated elements; (f) Photograph of the SPT-3G detector array taken before its final integration with the detector cryostat. The ten white hexagons are AR-coated lenslet arrays.

wrinkling or tearing. On flat surfaces we use a pattern that minimizes waste of the Rogers Corporation materials. Projections of the seam layout onto a plane parallel to the optics’ flat surfaces are shown in Figure 7. Additional details regarding the manufacture of both coatings, including production time tables, are given in [18].

The seams in each AR coating layer are <100 µm wide and conservatively estimated to occupy <0.5% of the total optical area of a lens. Even at the high-frequency edge of the 220 GHz SPT-3G observing band, $D_{seam}/\lambda < 0.1$. Therefore, we anticipate scattering loss due to the seams to be dominated by reflective and absorptive loss due to the AR coating and bulk alumina, respectively. We expect the AR coating seams will cause sidelobes in the SPT beam because they will appear as mm scale discontinuities at the primary reflector. The primary reflector itself is composed of 218 panels separated by ~1 mm gaps, which are filled by low-profile beryllium-copper spring flanges [19–21]. These discontinuities are known to cause sidelobes due to scattering, and their effects on the PSF have been simulated. We plan to include the effects of the AR coating seams in a new study of primary reflector sidelobes, but that analysis is outside the scope of this work.
Simulated effect of LDPE bonding layers on transmittance of lens-prescription coating

Fig. 4: Modeled transmittance of a single-surface, lossless lens-prescription coating with (blue) and without (red) LDPE bonding layers on a semi-infinite lossless alumina substrate. The modeled response of a lens-prescription coating (black), which is self-bonded and does not use LDPE, is shown for comparison. The refractive indices used in the simulations are the 300 K measured values from Table 1, except for that of LDPE which is adopted from [16]. The difference between the lens-prescription coating without LDPE and the lenslet-prescription coating lies in the low-dielectric layer: the lens prescription uses Zitex G-115; the lenslet prescription uses Porex PM-23J. The vertical grey bars mark the SPT -3G 95 GHz, 150 GHz, and 220 GHz observing bands, respectively. LDPE bonding layers affect the response of the coating at the level of a few percent, boosting transmittance in the 95 GHz and 150 GHz bands and depressing it in the 220 GHz band. The mean in-band transmittance is given for each band in blue (top), red (middle), and black (bottom) text, corresponding to simulations of the lens-prescription coating with LDPE, the lens-prescription coating without LDPE, and the lenslet-prescription coating, respectively.

Fig. 5: Photograph of the AR-coated SPT-3G collimator lens illustrating its radius of curvature. The lens is ~69 mm thick at its center.

3. Experimental procedure

We used a Winston cone-coupled, cryogenic bolometer and Michelson Fourier transform spectrometer (FTS) to characterize the performance of the lens- and lenslet-prescription coatings and their constituent materials between 150 GHz and 350 GHz at ~300 K and ~77 K. The monolithic silicon bolometer is described in [22]; the FTS design is described in [23], and is similar to the COBE/FIRAS design [24]. We conducted two rounds of sample-in/sample-out measurements to determine the transmittance of the samples. First we measured the uncoated sample substrates to establish a baseline response for each substrate. Then we coated the substrates and measured the samples twice more: once warm, and once cold. A more detailed
Fig. 6: We chose the illustrated seam patterns in an effort to minimize AR coating material waste while covering the largest possible area without the material wrinkling. Zitex G-115 is very compliant, so we were able to use it in its manufactured form. The RO3035 and RO3006 materials, however, are somewhat stiffer and prone to tearing. For this reason we selected a radially symmetric petal-like pattern for the curved surfaces. The RO3035 and RO3006 seam pattern for flat surfaces provided the most efficient practical use of the materials. (a) Seam layout for the RO3035 and RO3006 layers on curved surfaces. Sections were clocked and scaled as necessary to minimize seam overlap; (b) Seam layout for the Zitex G-115 layer on both flat and curved surfaces; (c) Seam layout for the RO3006 and RO3035 layers on flat surfaces. Sections were clocked to minimize seam overlap. Projections of the seams for both the lenses and infrared filter are shown in Figure 7.

Fig. 7: Projections of the seam layout for the three coated SPT-3G lenses (a) and the single coated infrared filter (b) onto a plane parallel with the optics’ flat surfaces. The projections show all three coating materials on both sides of the large-format optics: Zitex G-115 (dotted), RO3035 (dashed), and RO3006 (dot-dot-dashed). Flat/bottom surfaces are marked in blue and curved/top surfaces are marked in red.

explanation of the sample preparation and measurement follows in the next subsections.

3.1. Sample preparation

Taken by themselves, the individual AR coating materials were too thin to yield useful transmission spectra. Therefore, we used CoorsTek AD-995 alumina discs (152.4 mm outer diameter × 6.35 mm thick) as a mounting substrate to produce Fabry-Perot-like interference spectra. The discs were all members of the same powder and firing batch, so we did not expect significant variations in their properties. Nevertheless, we measured the transmission spectra of each bare alumina disc in order to establish a baseline and decouple the substrate properties from those of...
We assigned each substrate a coating material to be laminated to the substrate by a vacuum-bagging process, using ~25.4 µm thick LDPE as the bonding agent. Before laminating the samples, we measured the thickness of every layer of every sample at 20 positions spread across its ~150 mm diameter surface using a digital micrometer perpendicularly mounted to a granite flat-surface plate. Doing so allowed us to check for thickness gradients across the layers (we saw no evidence of this) and provided an average layer thickness that we used later during the data analysis phase.

Both sides of each substrate were coated by a single, stock-thickness layer of dielectric material, with the exception of two discs that were prepared using the complete, multilayer lens- and lenslet-prescription coatings. In total, we prepared six sample discs: Zitex G-115, Porex PM-23J, Rogers RO3035 bondply, Rogers RO3006 bondply, lenslet prescription, and lens prescription. We also had one 25.4 mm thick alumina sample that we did not coat, the purpose of which was to characterize attenuation in the bulk alumina. The thick alumina sample came from a different powder and firing batch than the coated samples.

3.2. Experiment set up

We used a chopped thermal source as the input signal to the FTS. The output of the FTS was collimated through the test sample and then focused onto a cryogenic bolometer by two nylon lenses ($n = 1.727$; Figure 8) [16]. The bolometer was read out by an analog-to-digital converter and data acquisition software. We minimized stray reflections by covering surfaces along the optical path with Eccosorb HR-10, a strong mm wave absorber.

![Conceptual diagram of the experiment's optical chain (left) and a detailed diagram of the optics stack assembly (right). Eccosorb HR-10 (not shown) was attached to surfaces of the optics stack assembly along the optical path in order to minimize stray reflections. The liquid helium-cooled detector dewar contains a monolithic silicon bolometer that is coupled via a Winston cone. Dimensions are not to scale.](image)

Our procedure for a measurement was to conduct a reference scan set with a clear optical path (sample-out), then a test scan set with the sample placed in the optical path (sample-in). Each scan set produced between three and nine interferograms. We calculated the Fourier transform of each interferogram in a scan set, then averaged those spectra to obtain the averaged spectrum for the set. We then calculated the transmittance spectrum by taking the ratio of the sample-in average spectrum to the sample-out average spectrum.

3.3. Additional measurements

The reflectance of a lens-prescription sample was measured using a reflectometer at the University of Michigan; the reflectometer design is described in [25]. The sample was measured at a 10°
angle of incidence between \( \sim 90 \text{ GHz} \) and \( \sim 180 \text{ GHz} \). Though the AR coating was prepared in the same manner as above, the reflectometer-tested sample employed an alumina substrate of different formulation to CoorsTek AD-995.

We also performed a vector network analyzer (VNA; Keysight 8510C) single-port S11 measurement of the same lens-prescription sample used in the FTS tests. The VNA signal was coupled to free space by a WR-10 rectangular horn antenna, and collimated by a 90° refocusing mirror. The sample was placed at a position where it filled the beam. The normal-incidence S11 measurement ranged from 75 GHz to 110 GHz and was calibrated to an aluminum mirror (short) and mm-wave absorber (load). We employed time-domain gating to minimize spurious signals from within the room and at interfaces throughout the waveguide set-up leading to the feedhorn.

### 4. Results

The cryogenic bolometer used in the FTS tests was responsive above \( \sim 130 \text{ GHz} \) and low-pass filtered at \( \sim 600 \text{ GHz} \), so we restricted our analysis to frequencies between 150 GHz and 350 GHz, where the uncertainties are smallest. We expect the measurement uncertainties to be dominated by statistics rather than systematics: the change in detector response over the course of a full sequence of reference and test measurements (<10 min) was negligible, and other systematics were eliminated due to the sample-in/sample-out measurement strategy.

In our analysis, we first extracted the refractive index of the uncoated, 6.35 mm thick alumina samples by modelling them as lossy dielectric slabs following [27]. Due to the low loss tangent of alumina, measurements of these thin substrates were not a good probe of the material’s loss. Therefore, we used measurements of the 25.4 mm thick alumina sample to constrain the loss tangent of the material. Placing limits on the alumina optical properties allowed us to better decouple the effects of the alumina from those of the AR coating plastics.

We used the characteristic matrix method to fit for the refractive index and loss tangent of the AR coating materials in the single-layer samples, using the previously determined alumina refractive index and loss tangent, the measured layer thicknesses, and an assumed refractive index and loss tangent for the LDPE bonding layer as model constraints [28, 29]. We adopted the LDPE refractive index and loss tangent from [16] that best matched the measurement’s frequency and temperature conditions. We used the resulting fit values for the AR material properties (i.e., the inferred refractive indices and loss tangents) and adoptive LDPE values to simulate the response of the lens- and lenslet-prescription coatings, which we then compared to measurements (Figure 9 and Figure 10). We accounted for changes in material thickness due to thermal contraction at 77 K using CTE values from existing literature [16, 30–32]. At 77 K the PTFE layers shrink by <2%, and the effect on \( n \) is small compared to uncertainties in the cold measurement; changes in the alumina at 77 K are even smaller.

We report the inferred material properties of the AR coating materials in Table 1. In Table 2 we report the average transmittance and associated 1\( \sigma \) uncertainties of the lens- and lenslet-prescription samples, measured before and after AR coating. The coatings improve transmittance through their alumina substrates by \( \sim 30\% \) in the 150 GHz and 220 GHz SPT-3G observing bands. Uncertainties in the FTS data are large in the 95 GHz band, but simulations and reflectance measurements suggest the coatings perform similarly there.

We obtained reflectance measurements of the lens-prescription coating in addition to the FTS measurements (Figure 11), and present those data here. We discuss these data in particular in § 5.1.

### 5. Discussion

Measuring the dielectric loss of these materials is challenging, especially if the material under test has a particularly small expected loss tangent, or if it is thin relative to the target wavelength.
Table 1: Inferred material optical properties and ±1σ uncertainties at 150 GHz

<table>
<thead>
<tr>
<th>Material</th>
<th>300 K</th>
<th>77 K</th>
</tr>
</thead>
<tbody>
<tr>
<td></td>
<td>300 K</td>
<td>77 K</td>
</tr>
<tr>
<td></td>
<td>$n$</td>
<td>$\tan \delta \times 10^{-4}$</td>
</tr>
<tr>
<td>Porex PM-23J</td>
<td>1.292(3)</td>
<td>&lt; 1a</td>
</tr>
<tr>
<td>Zitex G-115</td>
<td>1.234(3)</td>
<td>&lt; 1</td>
</tr>
<tr>
<td>Rogers RO3035</td>
<td>1.679(2)</td>
<td>43(16)</td>
</tr>
<tr>
<td>Rogers RO3006</td>
<td>2.249(3)</td>
<td>97(14)</td>
</tr>
<tr>
<td>CoorsTek AD-995</td>
<td>3.112(1)</td>
<td>49(6)</td>
</tr>
</tbody>
</table>

a Due to the sensitivity limits of the experiment, we interpret these values to be an upper limit on the loss tangent for the corresponding materials. The Zitex loss tangent is in close agreement with published values [33]; we expect the Porex to have similar properties.

Table 2: Sample average transmittance and ±1σ uncertainties at 300 K and 77 K

<table>
<thead>
<tr>
<th>T [K]</th>
<th>Substrate</th>
<th>State</th>
<th>Observing band transmittance [%]</th>
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<tbody>
<tr>
<td></td>
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<td>95 GHza</td>
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<tr>
<td>300</td>
<td>Lens</td>
<td>coated</td>
<td>90(70)</td>
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<tr>
<td></td>
<td></td>
<td>bare</td>
<td>≤ 100</td>
</tr>
<tr>
<td></td>
<td>Lenslet</td>
<td>coated</td>
<td>≤ 100</td>
</tr>
<tr>
<td></td>
<td></td>
<td>bare</td>
<td>≤ 100</td>
</tr>
<tr>
<td>77</td>
<td>Lens</td>
<td>coated</td>
<td>90(70)</td>
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<tr>
<td></td>
<td></td>
<td>bare</td>
<td>≤ 100</td>
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<tr>
<td></td>
<td>Lenslet</td>
<td>coatedb</td>
<td>—</td>
</tr>
<tr>
<td></td>
<td></td>
<td>bare</td>
<td>≤ 100</td>
</tr>
</tbody>
</table>

a We include the 95 GHz column for completeness, but consider the results to be an upper limit on sample transmittance. Uncertainties in these data are large due to the bolometer’s responsivity cut-off at ~130 GHz.
b The lenslet-prescription coating delaminated from the substrate upon cooldown, so we are missing 77 K data for that sample.
Many of the materials are only readily available as thin sheets, so it was necessary to mount them to a substrate before optical testing. Unfortunately, substrates and bonding layers add additional complexity and degeneracy to the problem. In this work, we first measured the bare alumina substrates in an attempt to break that degeneracy, but were not completely successful in doing so. We recognize that the error bars in Figure 9 and Figure 10 are large and that our results would benefit from additional measurements, but such measurements are currently out of our reach for logistical and financial reasons. Rather than indefinitely delay, we choose to report the results we have now with the hope that other researchers may benefit from our experience.

The lenslet-prescription coating did not survive the cryogenic optical test—the PTFE coating delaminated from one side of the alumina disc on cooldown to 77 K. Delamination of the lenslet-prescription coating was consistent with our previous experience in cryogenic tests. We have found the lenslet-prescription coating is robust from ~5 mm to ~25.4 mm diameter, but tends to delaminate on cooldown to 77 K at larger diameters (the sample coating used in this work was ~150 mm diameter). Cutting a perimeter around each 5 mm diameter lenslet allows us to manage the differential thermal contraction between the alumina lenslets, the silicon seating wafer, and the PTFE-based AR coating materials. In comparison, the lens-prescription coating is robust up to ~700 mm diameter. We do not have a good physical model for why this is the case, but one hypothesis is that the intermediate LDPE layers of the lens-prescription coating distribute thermal stresses more uniformly throughout the coating.

That the lenslet-prescription coating delaminates at all raises the question of how often the event occurs, particularly at the size scale of the fielded lenslet arrays. During the 2018/2019 austral summer season we inspected lenslet arrays that had been installed at the SPT-3G survey camera commissioning (austral 2016/2017 summer). Most of the inspected lenslet arrays had
Fig. 10: Measured transmittance of the lens-prescription coating at 77 K. We conductively cooled the sample through the edges of the discs using liquid nitrogen. This allowed the interior of the sample holder (above the surface of the sample and liquid-phase nitrogen) to be a predominantly nitrogen gas environment, preventing frost build-up on the sample. The solid blue line and light-blue shaded region are the measurement data and associated 1σ uncertainties; the red line is the model, which is produced using best-fit values for the optical properties of each material. The vertical grey bars mark the SPT-3G 95 GHz, 150 GHz, and 220 GHz observing bands, respectively. The passband of the bolometer used in the experiment was ~130 GHz to ~600 GHz, but we restricted the fit region to 150 GHz to 350 GHz. The lens-prescription data curve and associated error bars are the result of nine interferograms. As discussed in §5, the lenslet-prescription coating used for testing was a much larger diameter than the coatings currently deployed in the SPT-3G survey camera (~150 mm vs. ~5 mm). The tested lenslet-prescription coating did not survive the cooldown to 77 K because we did not take our usual steps to mitigate the CTE mismatch between the coating and substrate, hence we do not show data for that sample.

been thermally cycled from 300 K to ~300 mK five or more times (accounting for laboratory testing as well as integrated testing at the South Pole). At that time we found 97.9% of the pixels had retained their coatings. Nearly all cases of coating delamination shared the same cause: the coated pixels were not fully separated from their neighbors at the corners during the laser dicing step. This was caused by an error in the laser program that we have identified and corrected, so we do not expect this problem going forward.

Though we report a single number for the inferred refractive index (n) and loss tangent (tan δ) in Table 1, it should be remembered that n and tan δ are frequency-dependent quantities. We take the properties of these materials at 150 GHz as a convenient proxy for their response across the full SPT-3G observing bandwidth (~77 GHz to ~252 GHz). The quantities n and tan δ are also temperature-dependent, a distinction we make here. It is worth noting that while tan δ generally decreases with decreasing temperature (for a given frequency and sufficiently wide range of temperature T), it does not necessarily do so monotonically. The functional form of tan δ(T) can vary between materials, and the magnitude of tan δ(T) may vary between materials that are nominally the same.

Our findings for Zitex G-115’s refractive index and loss tangent generally agree with the values reported in [33], but we find a lower refractive index and higher loss tangent in our alumina sample than reported in [16]. We expect scattering loss at the porous Zitex/Porex layer to be negligible—even at the highest SPT-3G observing frequencies—due to the small size of the pores (typically 1 µm to 3 µm) [34, 35]. To the authors’ knowledge, measurements of RO3035 and RO3006 at these frequencies have not yet been published.

The increased RO3035 and RO3006 loss at 77 K relative to 300 K is a surprising feature
Fig. 11: Measured reflectance of lens-prescription coatings at room temperature. The dashed black line is the best-fit model to our FTS measurements of the lens-prescription coating, the blue curve shows reflectometer data, and the red curve shows single-port VNA data. The vertical grey bars mark the SPT-3G 95 GHz and 150 GHz observing bands. The sample substrate used in the FTS and VNA measurements was a different formulation than the substrate used in the reflectometer measurement. Only accounting for the 10° incident angle used in the reflectometer measurement (vs. the normal-incidence VNA measurement) does not explain the difference in the data. However, accounting for incident angle and tuning the refractive indices of the sample substrates does. We found that increasing the alumina substrates’ refractive index by about 3% recovers more of the signal. But this is a somewhat arbitrary approach and doesn’t tell us much, since we should also expect the refractive indices of the AR coating materials to be changing.

It is better to avoid multi-material samples and measure a target material in isolation, if the goal is to understand that material’s optical properties. There is less margin for error as optical design tolerances become more stringent, and familiar approximations may not be as useful as we start to use old materials in new ways. Developing a better understanding of the temperature- and frequency-dependent optical properties of materials (in particular those with very low loss) will require us to try new characterization techniques. Quasi-optically coupled VNA techniques have been employed at cryogenic temperatures and THz frequencies with good results [36], and would be a good option for us going forward. In addition, shielded dielectric resonator (SDR) methods could allow us to begin to probe these optical properties, even for thin samples. SDR methods are an established technique in materials science and well-suited to characterizing low-loss materials [37], but have yet to become standard in the CMB field.

5.1. Reflectance measurements

The mean reflectance of the lens-prescription sample measured via reflectometer is ~3.1% in the probed portion of the 95 GHz SPT-3G observing band, and <1% across the 150 GHz band. In comparison, the mean reflectance of the lens-prescription sample measured via VNA is
~2.8 % throughout the 95 GHz band. We did not have the necessary equipment (e.g. a frequency extender) to make a VNA measurement in the 150 GHz band, so we do not have comparable data there.

As stated in § 3.3, the lens-prescription sample measured at the University of Michigan employed a different alumina substrate to the sample measured via FTS and VNA single-port S11. The substrate used in the reflectometer measurement was not produced by CoorsTek. We did not measure that specific substrate before coating it, but we have found substrates from the same batch have $n_{300K} \approx 3.05$, in contrast to the CoorsTek samples which have $n_{300K} \approx 3.11$. Therefore, we do not expect the VNA and reflectometer data to match perfectly.

The best-fit optical properties to the FTS data are not well-matched to the S11 data in terms of fringe periodicity; amplitude is a closer match, though still imperfect (Figure 11). Our fit parameters are derived from a higher frequency range than the S11 measurement, so some drift in the optical properties of the materials is anticipated due to the frequency-dependent nature of the dielectric function.

We are able to better model the VNA and reflectometer data by assuming the inferred optical properties of the materials in Table 1 and tuning the refractive indices of the samples’ alumina substrates. In both cases, increasing the substrate refractive indices by ~3 % almost entirely recovers the fringing periodicity, as well as much of the amplitude. However, the refractive indices of the other materials should also be changing with frequency, so varying only the alumina refractive index does not tell us much except that the “effective index” of each sample appears to increase toward lower frequency. Carefully quantifying the frequency-dependent dielectric functions describing the optical properties of these materials is beyond the scope of the current analysis and will require further experimentation.

5.2. Modeling the response of an isolated, AR coated SPT-3G lens and lenslet

For logistical reasons, we did not directly measure the optical efficiency of the finished, AR coated lenses and lenslets in isolation before their integration with the rest of the SPT-3G survey camera. Table 3 enumerates an effort to use the inferred material properties of the AR coating materials and alumina at 77 K (Table 1), as well as the known geometry of the SPT-3G lenses and lenslets, to estimate the optical efficiency of those elements after the fact. We assume a 2.5 mm thick lenslet and 69 mm thick lens for the respective models. We chose 69 mm because that is the approximate distance traveled by the central ray through the thickest SPT-3G lens (the collimator), which makes the values in Table 3 a conservative performance estimate. We modeled the optics as multilayer, lossy dielectric slabs using the characteristic matrix method described in [28]. The transmittance (T), reflectance (R), and loss (L) values are the result of 10000 realizations of normally incident waves on both lens and lenslet models. At every realization, $n$ and $\tan \delta$ for each material were randomly sampled from within the ±1σ regions in Table 1. Scattering is not included in the model. It is important to note that Table 3 does not represent the end-to-end optical efficiency of the SPT-3G experiment, which includes many additional factors. Rather it suggests the level of performance a CMB experiment with a similar AR coating and lens material might expect from a lens or lenslet.

Alumina is the dominant material in both the lens and lenslet systems: it is the thickest material and has the highest refractive index. The dielectric loss of a sintered alumina part is known to depend on the conditions under which it was manufactured, but there is not a good model to predict a part’s loss tangent $a priori$ (nor even after the fact in the absence of non-destructive forensic methods). Since the sintering process itself depends on the geometry of the part, there is no guarantee that the internal microstructure (and by extension, the loss tangent) of a 2.5 mm, 6.35 mm, 25.4 mm, and 69 mm thick part is identical. If the loss tangent of an alumina part must be known with high accuracy, then the part should be measured directly—the loss tangent of a proxy such as a witness blank is not necessarily a good indicator, even if it came from the same
Table 3: Modeled response of an SPT-3G lens and lenslet with associated $\pm 1\sigma$ uncertainty for each SPT-3G observing band

<table>
<thead>
<tr>
<th></th>
<th>2.5 mm-thick lenslet</th>
<th>69 mm-thick lens</th>
</tr>
</thead>
<tbody>
<tr>
<td></td>
<td>95 GHz</td>
<td>150 GHz</td>
</tr>
<tr>
<td>T</td>
<td>0.955(2)</td>
<td>0.904(3)</td>
</tr>
<tr>
<td>R</td>
<td>0.009(2)</td>
<td>0.045(1)</td>
</tr>
<tr>
<td>L</td>
<td>0.037(3)</td>
<td>0.051(3)</td>
</tr>
</tbody>
</table>

*a T, R, L refer to transmittance, reflectance, and loss, respectively.

6. Conclusion

We have developed two prescriptions to produce PTFE-based, broadband, mm-wave AR coatings for cryogenic polycrystalline alumina optics: one for large-diameter optics, the other for arrays of lenslets. Both coatings increase transmittance through an alumina substrate by $\sim 30\%$ in the 150 GHz and 220 GHz SPT-3G observing bands, and are expected to perform similarly in the 95 GHz band. The total cost of materials needed to AR coat both sides of a $\sim 700$ mm diameter alumina optic using the method described in this paper is about $\$1500$ USD. (This figure excludes the cost of the optic itself.) The cost of materials required for the lenslet array and lenslet-prescription coating is approximately $\$3$ USD per pixel ($\sim \$1$ for the coating material, and $\sim \$2$ for the lenslet).

The lamination process developed for lenslets is general to PTFE-based materials, and can be adapted to create coatings for different frequency bands. A major advantage of the lenslet fabrication process is its throughput. Using this method, we can fabricate a lenslet array in $\sim 24$ h, which will be important for the future large-scale projects. While epoxy-based lenslet coatings have also been demonstrated with good results [38], fabrication of a single two-layer AR coated lenslet array takes significantly longer and the two-layer coating is not well-suited to experiments with three-band detectors. The process developed for large-format lenses can also be adapted for different frequencies. However, the geometry of large-format lenses is a critical factor in the application of the technique described in this paper. While we have demonstrated the technique in the case of plano-convex lenses, geometries such as meniscus lenses will require additional engineering considerations.

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Disclosures

The authors declare no conflicts of interest.


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